Dual TrenchPLUS FET Logic Level FET Rev. 03 — 15 July 2010

Product data sheet

#### **Product profile** 1.

### **1.1 General description**

Dual N-channel enhancement mode field-effect power transistor in SO20. Device is manufactured using NXP High-Performance (HPA) TrenchPLUS technology, featuring very low on-state resistance, integrated current sensing transistors and over temperature protection diodes.

Power distribution

Solenoid drivers

### 1.2 Features and benefits

Integrated current sensors Integrated temperature sensors

#### **1.3 Applications**

- Lamp switching
- Motor drive systems

#### 1.4 Quick reference data

#### Table 1. **Quick reference data**

Parameter	Conditions	Min	Тур	Max	Unit
FET2 static charact	eristics				
drain-source on-state resistance	$V_{GS} = 5 \text{ V}; I_D = 10 \text{ A};$ $T_j = 25 \text{ °C}; \text{ see } Figure 15;$ see Figure 16	-	14.5	17	mΩ
ratio of drain current to sense current	T <sub>j</sub> = 25 °C; V <sub>GS</sub> = 5 V; see <u>Figure 17</u>	4963	5514	6065	A/A
drain-source breakdown voltage	$\begin{split} I_D &= 250 \; \mu\text{A}; \; \text{V}_{\text{GS}} = 0 \; \text{V}; \\ T_j &= 25 \; ^{\circ}\text{C} \end{split}$	65	-	-	V
	FET2 static charact drain-source on-state resistance ratio of drain current to sense current drain-source breakdown	FET2 static characteristicsdrain-source $V_{GS} = 5 \text{ V}; I_D = 10 \text{ A};$ on-stateon-state $T_j = 25 \text{ °C}; \text{ see } Figure 15;$ resistanceratio of drain $T_j = 25 \text{ °C}; V_{GS} = 5 \text{ V};$ see Figure 17currentsense currentdrain-source $I_D = 250 \ \mu\text{A}; V_{GS} = 0 \text{ V};$ $T_j = 25 \text{ °C}$	FET2 static characteristicsdrain-source $V_{GS} = 5 \text{ V}; I_D = 10 \text{ A};$ on-state-on-state $T_j = 25 \text{ °C}; \text{ see Figure 15};$ resistance-ratio of drain $T_j = 25 \text{ °C}; V_{GS} = 5 \text{ V};$ current to sense4963currentsee Figure 17 current4963drain-source $I_D = 250 \ \mu\text{A}; V_{GS} = 0 \text{ V};$ breakdown65	FET2 static characteristicsdrain-source $V_{GS} = 5 \text{ V}; \text{ I}_D = 10 \text{ A};$ on-state-14.5on-state $T_j = 25 \text{ °C}; \text{ see Figure 15};$ resistance-14.5ratio of drain $T_j = 25 \text{ °C}; \text{ V}_{GS} = 5 \text{ V};$ current to sense4963 5514drain-source $I_D = 250 \ \mu\text{A}; \ V_{GS} = 0 \text{ V};$ breakdown65	FET2 static characteristicsdrain-source $V_{GS} = 5 \text{ V}; I_D = 10 \text{ A};$ on-state-14.517on-state $T_j = 25 \text{ °C}; \text{ see Figure 15};$ resistance-14.517ratio of drain $T_j = 25 \text{ °C}; \text{ V}_{GS} = 5 \text{ V};$ current to sense current496355146065drain-source $I_D = 250 \ \mu\text{A}; \ V_{GS} = 0 \text{ V};$ breakdown65



### Dual TrenchPLUS FET Logic Level FET

### 2. Pinning information

Table 2.	Pinning	j information		
Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G1	gate 1		
2	IS1	current sense 1	— 20 11 月日日日日日日日	D1 A1 D2 A2
3	D1	drain 1		FET1 FET2
4	A1	anode 1		
5	C1	cathode 1		
6	G2	gate 2		
7	IS2	current sense 2	SOT163-1 (SO20)	
8	D2	drain 2		G1 IS1 S1 KS1 C1 G2 IS2 S2 KS2 C2
9	A2	anode 2		003aaa745
10	C2	cathode 2		
11	D2	drain 2		
12	KS2	Kelvin source 2		
13	S2	source 2		
14	S2	source 2		
15	D2	drain 2		
16	D1	drain 1		
17	KS1	Kelvin source 1		
18	S1	source 1		
19	S1	source 1		
20	D1	drain 1		

### 3. Ordering information

Table 3. Ordering in	nformation		
Type number	Package		
	Name	Description	Version
BUK9MJJ-65PLL	SO20	plastic small outline package; 20 leads; body width 7.5 mm	SOT163-1

**Dual TrenchPLUS FET Logic Level FET** 

### 4. Limiting values

#### Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions		Min	Мах	Unit
FET1 and FET	Γ2					
V <sub>DS</sub>	drain-source voltage	25 °C ≤ T <sub>j</sub> ≤ 150 °C		-	65	V
V <sub>DGR</sub>	drain-gate voltage	$R_{GS} = 20 \text{ k}\Omega; 25 ^{\circ}\text{C} \le T_j \le 150 ^{\circ}\text{C}$		-	65	V
V <sub>GS</sub>	gate-source voltage			-15	15	V
I <sub>D</sub>	drain current	$V_{GS} = 5 \text{ V}; \text{ T}_{sp} = 25 \text{ °C}; \text{ see } \frac{\text{Figure 1}}{1}$	<u>[1][2]</u>	-	11.6	А
		$V_{GS}$ = 5 V; $T_{sp}$ = 100 °C; see <u>Figure 1</u>	<u>[1][2]</u>	-	7.4	А
I <sub>DM</sub>	peak drain current	$T_{sp}$ = 25 °C; single pulse; $t_p \le 10 \ \mu s$ ; see Figure 4		-	212	А
P <sub>tot</sub>	total power dissipation	T <sub>sp</sub> = 25 °C; see <u>Figure 2</u>		-	4.4	W
T <sub>stg</sub>	storage temperature			-55	150	°C
Tj	junction temperature			-55	150	°C
$V_{isol(FET-TSD)}$	FET to temperature sense diode isolation voltage			-	100	V
FET1 and FET	2 source-drain diode					
I <sub>S</sub>	source current	T <sub>sp</sub> = 25 °C	<u>[1][2]</u>	-	11.6	А
I <sub>SM</sub>	peak source current	single pulse; t <sub>p</sub> ≤ 10 µs; T <sub>sp</sub> = 25 °C		-	212	А
FET1 and FET	2 avalanche ruggedness					
E <sub>DS(AL)S</sub>	non-repetitive drain-source avalanche energy	$I_D$ = 11.6 A; $V_{sup}$ = 65 V; $V_{GS}$ = 5 V; $T_{j(init)}$ = 25 °C; unclamped; see <u>Figure 3</u>	<u>[3][4][5]</u>	-	494	mJ
FET1 and FET	2 electrostatic discharge					
V <sub>ESD</sub>	electrostatic discharge voltage	HBM; C = 100 pF; R = 1.5 k $\Omega$ ; all pins		-	0.15	kV
		HBM; C = 100 pF; R = 1.5 kΩ; pins 8, 11 and 15 to pins 6, 7, 12, 13 and 14 shorted		-	4	kV
		HBM; C = 100 pF; R = 1.5 kΩ; pins 3, 16 and 20 to pins 1, 2, 17, 18 and 19 shorted		-	4	kV

[1] Single device conducting.

[2] Continuous current is limited by package.

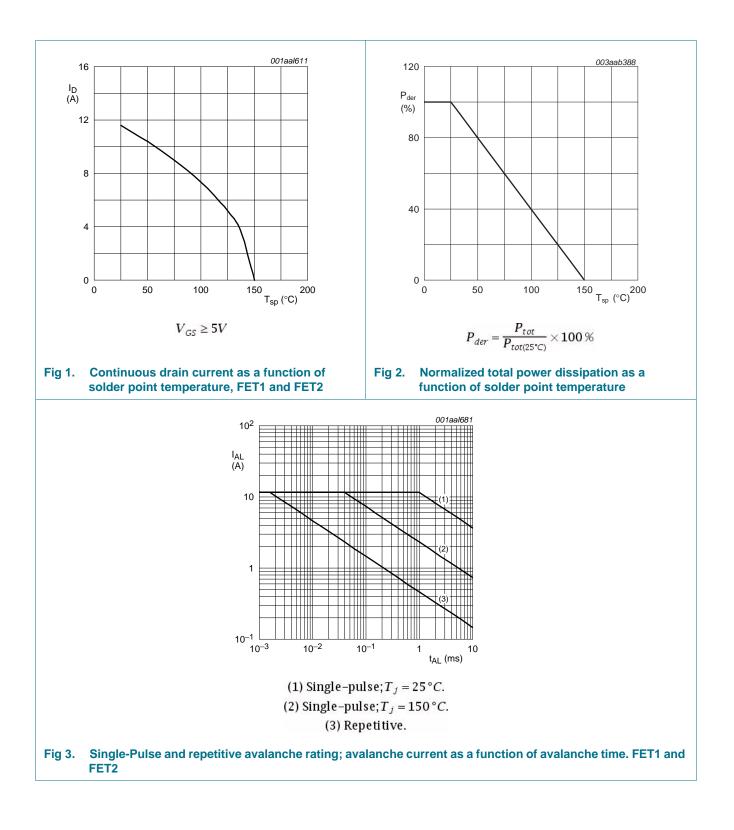
[3] Single-pulse avalanche rating limited by maximum junction temperature of 150 °C.

[4] Repetitive rating defined in avalanche rating figure.

[5] Refer to application note AN10273 for further information.

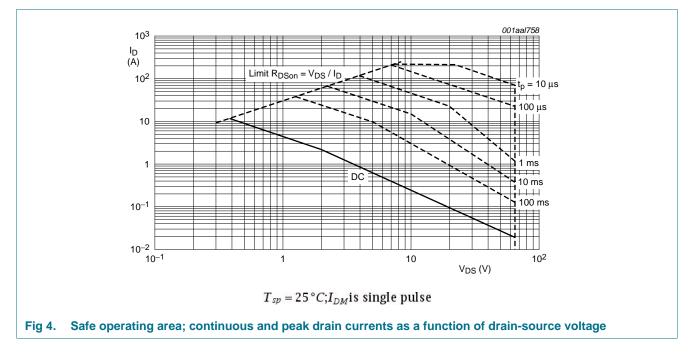
## **BUK9MJJ-65PLL**

#### **Dual TrenchPLUS FET Logic Level FET**



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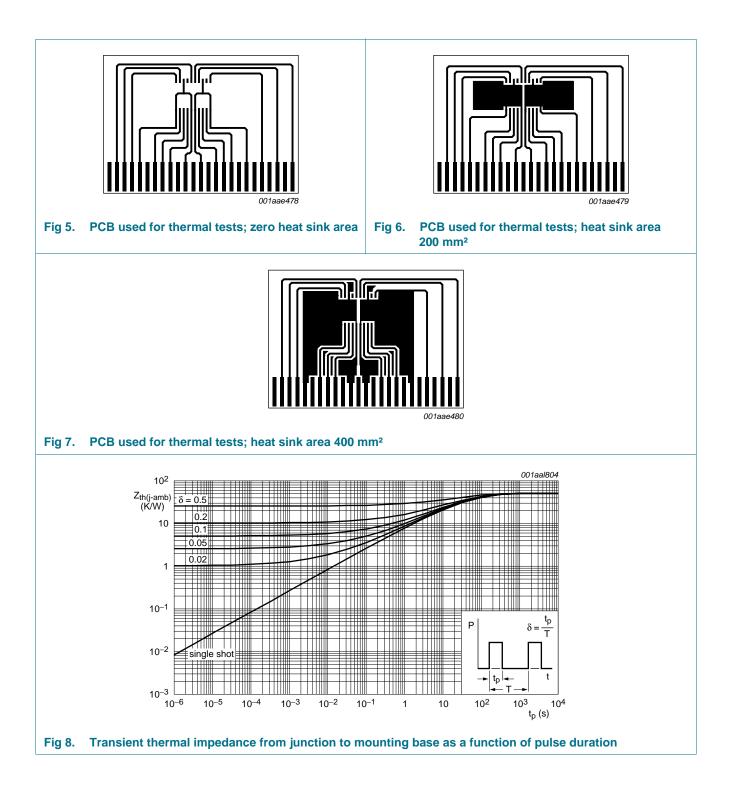
### 5. Thermal characteristics

#### Table 5.Thermal characteristics

Table J.	mermai characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
R <sub>th(j-sp)</sub>	thermal resistance	FET1	-	-	28	K/W
	from junction to solder point	FET2	-	-	28	K/W
R <sub>th(j-a)</sub> thermal resistance from junction to ambient	mounted on a printed-circuit board; both channels conducting; zero heat sink area; see Figure 5	-	73	-	K/W	
	mounted on a printed-circuit board; both channels conducting; 200 mm <sup>2</sup> copper heat sink area; see Figure 6	-	60	-	K/W	
	mounted on a printed-circuit board; both channels conducting; 400 mm <sup>2</sup> copper heat sink area; see Figure 7	-	51	-	K/W	
	mounted on a printed-circuit board; one channel conducting; zero heat sink area; see <u>Figure 5</u>	-	105	-	K/W	
	mounted on a printed-circuit board; one channel conducting; 200 mm <sup>2</sup> copper heat sink area; see <u>Figure 6</u>	-	90	-	K/W	
		mounted on a printed-circuit board; one channel conducting; 400 mm <sup>2</sup> copper heat sink area; see <u>Figure 7</u>	-	70	-	K/W

### **BUK9MJJ-65PLL**

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Dual TrenchPLUS FET Logic Level FET

### 6. Characteristics

Table 6.	Characteristics					
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
FET1 and	I FET2 static characteristics					
V <sub>(BR)DSS</sub>	drain-source	$I_D = 250 \ \mu A; \ V_{GS} = 0 \ V; \ T_j = 25 \ ^\circ C$	65	-	-	V
	breakdown voltage	$I_D = 250 \ \mu A; \ V_{GS} = 0 \ V; \ T_j = -55 \ ^\circ C$	59	-	-	V
V <sub>GSth</sub>	gate-source threshold voltage	$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 25 \text{ °C};$ see <u>Figure 13</u> ; see <u>Figure 14</u>	1	1.5	2	V
		$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 150 \text{ °C};$ see <u>Figure 13</u> ; see <u>Figure 14</u>	0.5	-	-	V
		$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = -55 \text{ °C};$ see <u>Figure 13</u> ; see <u>Figure 14</u>	-	-	2.3	V
I <sub>DSS</sub>	drain leakage current	$V_{DS} = 52 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}$	-	0.02	3	μΑ
		$V_{DS} = 52 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 150 \text{ °C}$	-	-	125	μA
I <sub>GSS</sub>	gate leakage current	$V_{DS} = 0 \text{ V}; V_{GS} = 15 \text{ V}; T_j = 25 \text{ °C}$	-	2	300	nA
	drain-source on-state resistance	V <sub>GS</sub> = 4.5 V; I <sub>D</sub> = 10 A; T <sub>j</sub> = 25 °C; see <u>Figure 15</u> ; see <u>Figure 16</u>	-	-	18.8	mΩ
		$V_{GS} = 5 \text{ V}; I_D = 10 \text{ A}; T_j = 25 \text{ °C};$ see <u>Figure 15</u> ; see <u>Figure 16</u>	-	14.5	17	mΩ
		$V_{GS} = 5 \text{ V}; I_D = 10 \text{ A}; T_j = 150 \text{ °C};$ see <u>Figure 15</u> ; see <u>Figure 16</u>	-	-	32.6	mΩ
		V <sub>GS</sub> = 10 V; I <sub>D</sub> = 10 A; T <sub>j</sub> = 25 °C; see <u>Figure 15</u> ; see <u>Figure 16</u>	-	-	15.5	mΩ
I <sub>D</sub> /I <sub>sense</sub>	ratio of drain current to sense current	$V_{GS}$ = 5 V; $T_j$ = 25 °C; see <u>Figure 17</u>	4963	5514	6065	A/A
S <sub>F(TSD)</sub>	temperature sense diode temperature coefficient	I <sub>F</sub> = 250 μA; 25 °C ≤ T <sub>j</sub> ≤ 150 °C; see <u>Figure 18</u>	-5.4	-5.7	-6	mV/K
V <sub>F(TSD)</sub>	temperature sense diode forward voltage	$I_F = 250 \ \mu\text{A}; \ T_j = 25 \ ^\circ\text{C}; \ \text{see} \ \underline{Figure \ 18}$	2.855	2.9	2.945	V

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Table 6.	Characteristics continued					
Symbol	Parameter	Conditions	Min	Тур	Мах	Unit
FET1 and F	ET2 dynamic characterist	ics				
Q <sub>G(tot)</sub>	total gate charge	$I_D = 10 \text{ A}; V_{DS} = 52 \text{ V}; V_{GS} = 5 \text{ V};$	-	30.8	-	nC
Q <sub>GS</sub>	gate-source charge	see Figure 19	-	6.5	-	nC
Q <sub>GD</sub>	gate-drain charge		-	13.5	-	nC
C <sub>iss</sub>	input capacitance	$V_{GS} = 0 V; V_{DS} = 25 V; f = 1 MHz;$	-	2660	-	pF
C <sub>oss</sub>	output capacitance	T <sub>j</sub> = 25 °C; see <u>Figure 20</u>	-	322	-	pF
C <sub>rss</sub>	reverse transfer capacitance		-	123	-	pF
t <sub>d(on)</sub>	turn-on delay time		-	32	-	ns
t <sub>r</sub>	rise time		-	59	-	ns
t <sub>d(off)</sub>	turn-off delay time		-	120	-	ns
t <sub>f</sub>	fall time		-	79	-	ns
L <sub>D</sub>	internal drain inductance	from pin to center of die	-	0.9	-	nH
L <sub>S</sub>	internal source inductance	from source lead to source bonding pad	-	2	-	nH
FET1 and F	ET2 source-drain diode					
V <sub>SD</sub>	source-drain voltage	I <sub>S</sub> = 10 A; V <sub>GS</sub> = 0 V; T <sub>j</sub> = 25 °C; see <u>Figure 21</u>	-	0.85	1.2	V
t <sub>rr</sub>	reverse recovery time	I <sub>S</sub> = 10 A; dI <sub>S</sub> /dt = -100 A/µs;	-	50	-	ns
Q <sub>r</sub>	recovered charge	$V_{GS} = -10 \text{ V}; \text{ V}_{DS} = 30 \text{ V}$	-	0.125	-	nC

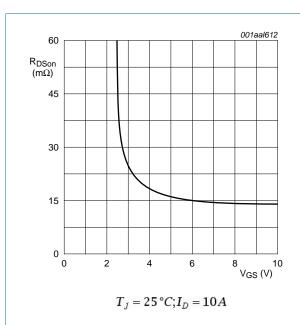
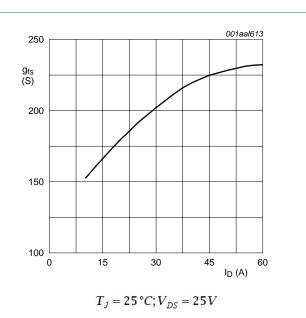
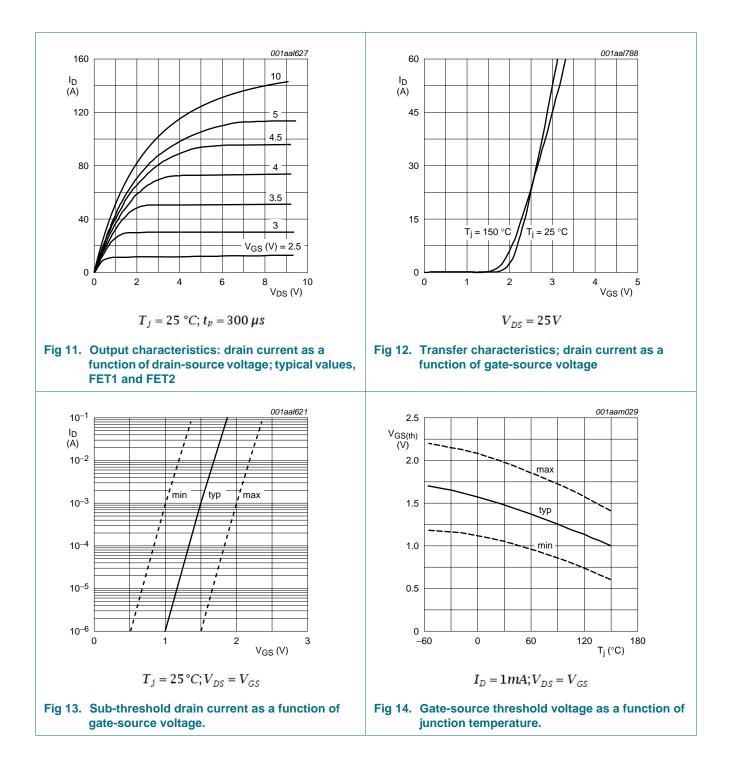


Fig 9. Drain-source on-state resistance as a function of gate-source voltage; typical values, FET1 and FET2



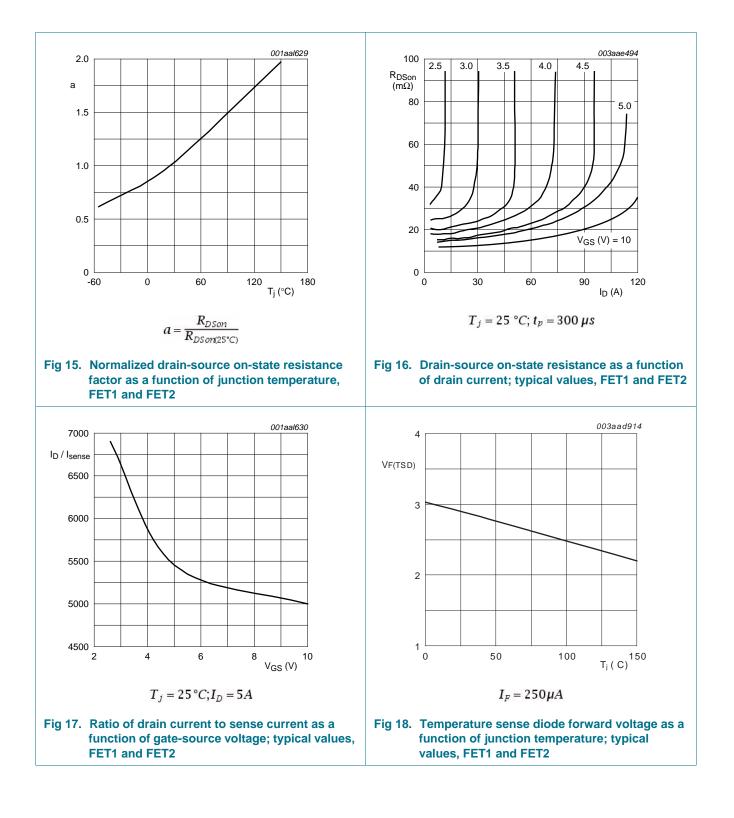


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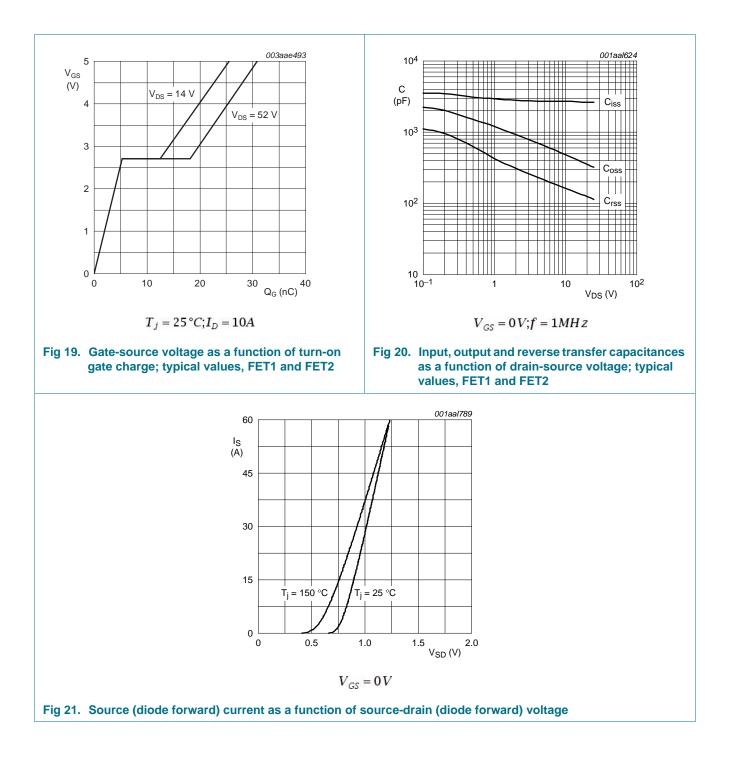
## **BUK9MJJ-65PLL**

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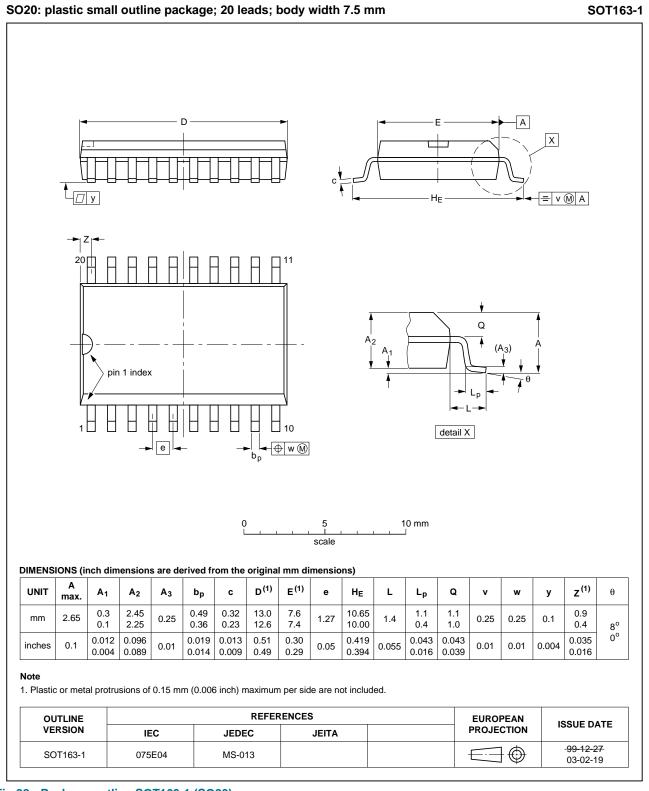
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### 7. Package outline



#### Fig 22. Package outline SOT163-1 (SO20)

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### 8. Revision history

Table 7.Revision h	istory			
Document ID	Release date	Data sheet status	Change notice	Supersedes
BUK9MJJ-65PLL v.3	20100715	Product data sheet	-	BUK9MJJ-65PLL v.2
Modifications:	<ul> <li>Various changes</li> </ul>	to content.		
BUK9MJJ-65PLL v.2	20100618	Product data sheet	-	-

**Dual TrenchPLUS FET Logic Level FET** 

### 9. Legal information

### 9.1 Data sheet status

Document status[1][2]	Product status <sup>[3]</sup>	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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